Power MOSFET

30 V, 44 A, Single N-Channel, μ8FL

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- DC-DC Converters
- Power Load Switch
- Notebook Battery Management

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage	V _{DSS}	30	٧		
Gate-to-Source Voltage	V _{GS}	±20	٧		
Continuous Drain		T _A = 25°C	Ι _D	13.3	Α
Current R _{θJA} (Note 1)		T _A = 80°C	1	9.9	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	2.09	W
Continuous Drain		T _A = 25°C	I _D	18.2	Α
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		T _A = 80°C		13.6	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C	P _D	3.9	W
Continuous Drain	State	T _A = 25°C	I _D	8.2	Α
Current R _{θJA} (Note 2)		T _A = 80°C	1	6.1	
Power Dissipation R _{0JA} (Note 2)		T _A = 25°C	P _D	0.79	W
Continuous Drain		T _C = 25°C	I _D	44	Α
Current R _{θJC} (Note 1)		T _C = 80°C]	33	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	23.6	W
Pulsed Drain Current	T _A = 25°0	C, t _p = 10 μs	I _{DM}	128	Α
Operating Junction and S	T _J , T _{stg}	-55 to +150	°C		
Source Current (Body Die	IS	20	Α		
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain-to-So $(T_J=25^{\circ}C,V_{DD}=50V,V_{DD}=0.1$ mH, $R_G=25\Omega)$ (E _{AS}	31	mJ		
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. This is the absolute maximum ratings. Parts are 100% tested at $T_J=25^{\circ}C$, $V_{GS}=10$ V, $I_L=17$ A, $E_{AS}=14$ mJ.

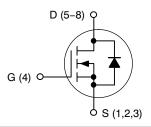


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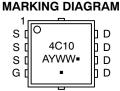
V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	7.4 mΩ @ 10 V	44 A
	11 mΩ @ 4.5 V	77 /

N-Channel MOSFET





WDFN8 (μ8FL) CASE 511AB



4C10 = Specific Device Code A = Assembly Location Y = Year

WW = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS4C10NTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel
NTTFS4C10NTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	5.3	
Junction-to-Ambient - Steady State (Note 4)	$R_{ heta JA}$	59.9	°C/W
Junction-to-Ambient - Steady State (Note 5)	$R_{ heta JA}$	157.8	*C/VV
Junction-to-Ambient - (t ≤ 10 s) (Note 4)	$R_{ heta JA}$	31.8	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS								
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V	
Drain-to-Source Breakdown Voltage (transient)	V _{(BR)DSSt}	$V_{GS} = 0 \text{ V}, I_{D(aval)} = 7.1 \text{ A},$ $T_{case} = 25^{\circ}\text{C}, t_{transient} = 100 \text{ ns}$		34			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /			14.5		mV/°C		
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25°C			1.0		
			T _J = 125°C			10	μΑ	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	= ±20 V			±100	nA	
ON CHARACTERISTICS (Note 6)	•			-		-	-	
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D :	= 250 μΑ	1.3		2.2	V	
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.5		mV/°C	
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		5.9	7.4	m-0	
		V _{GS} = 4.5 V	I _D = 15 A		8.8	11	mΩ	
Forward Transconductance	9 _{FS}	V _{DS} = 1.5 V, I _E) = 15 A		43		S	
Gate Resistance	R _G	T _A = 25°C			1.0		Ω	
CHARGES AND CAPACITANCES								
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			993		pF	
Output Capacitance	Coss				574			
Reverse Transfer Capacitance	C _{RSS}				163]	
Capacitance Ratio	C _{RSS} /C _{ISS}	V _{GS} = 0 V, V _{DS} = 15	V, f = 1 MHz		0.164			
Total Gate Charge	Q _{G(TOT)}				9.7			
Threshold Gate Charge	Q _{G(TH)}				1.5		1	
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$			2.8		nC	
Gate-to-Drain Charge	Q_{GD}				4.8		1	
Gate Plateau Voltage	V _{GP}				3.2		V	
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V; I _D = 30 A			18.6		nC	
SWITCHING CHARACTERISTICS (Note 7)								
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			9.0			
Rise Time	t _r				30]	
Turn-Off Delay Time	t _{d(OFF)}				14		- ns -	
Fall Time	t _f				7.0	Ì		

- 6. Pulse Test: pulse width \leq 300 $\mu\text{s},$ duty cycle \leq 2%.
- 7. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 7)	•		•	•	•	•
Turn-On Delay Time	t _{d(ON)}			6.0		- ns	
Rise Time	t _r	$\begin{aligned} &V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V}, \\ &I_D = 15 \text{ A}, R_G = 3.0 \Omega \end{aligned}$			25		
Turn-Off Delay Time	t _{d(OFF)}				18		
Fall Time	t _f			4.0			
DRAIN-SOURCE DIODE CHARACT	ERISTICS	-					-
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V},$ $T_{J} = 25^{\circ}\text{C}$			0.80	1.1	.,
		$V_{GS} = 0 \text{ V},$ $I_{S} = 10 \text{ A}$	T _J = 125°C		0.67		V
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			23.3		
Charge Time	t _a				12.7		ns
Discharge Time	t _b				10.6		
Reverse Recovery Charge	Q _{RR}	1		8.3		nC	

^{6.} Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
7. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

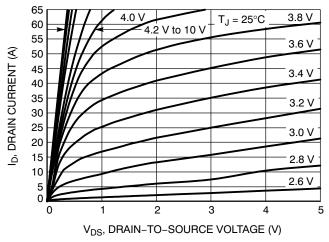


Figure 1. On-Region Characteristics

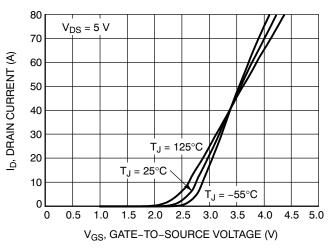


Figure 2. Transfer Characteristics

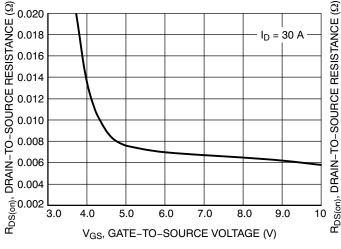


Figure 3. On-Resistance vs. V_{GS}

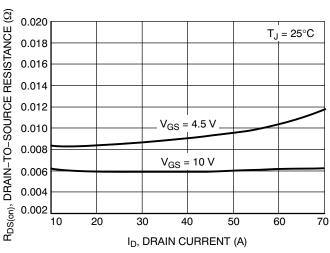


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

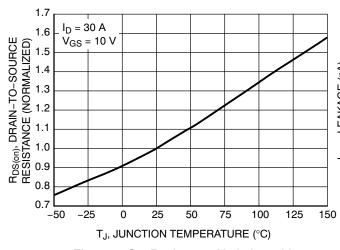


Figure 5. On–Resistance Variation with Temperature

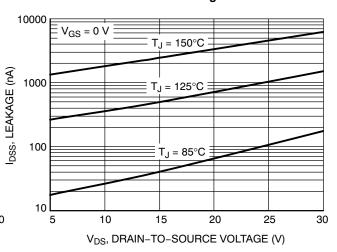


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

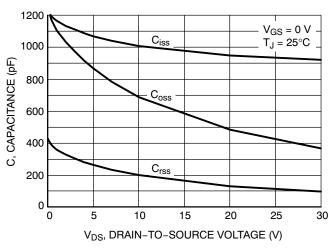


Figure 7. Capacitance Variation

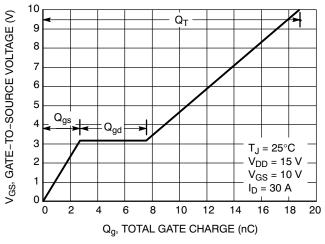


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

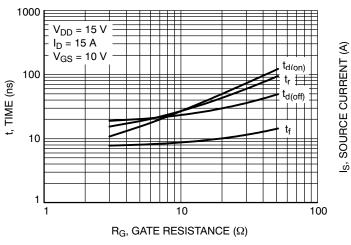


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

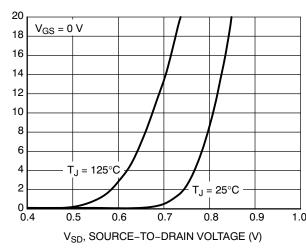


Figure 10. Diode Forward Voltage vs. Current

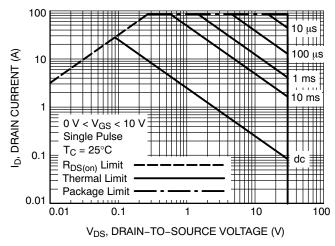


Figure 11. Maximum Rated Forward Biased Safe Operating Area

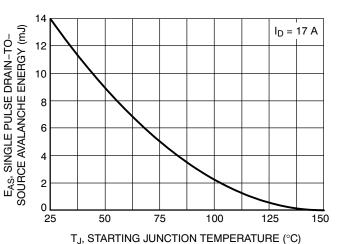


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL CHARACTERISTICS

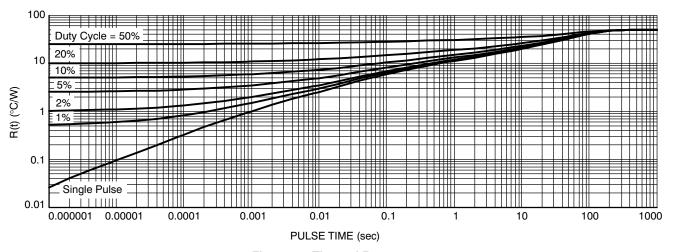


Figure 13. Thermal Response

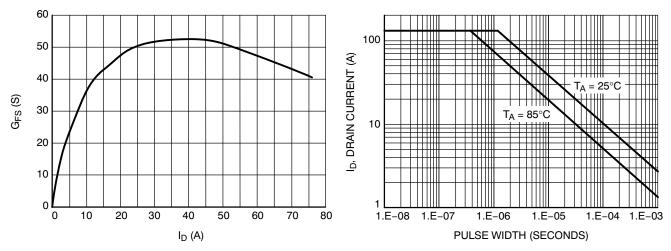
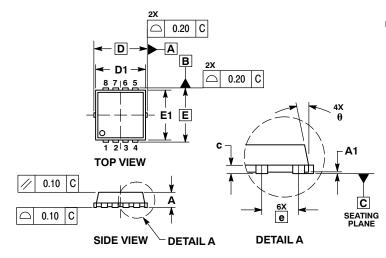


Figure 14. G_{FS} vs. I_D

Figure 15. Avalanche Characteristics

PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

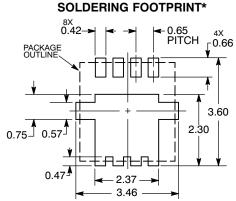


NOTES

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D	3.30 BSC			0.130 BSC			
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E		3.30 BSC	;	0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е	0.65 BSC			(0.026 BS	0	
G	0.30	0.41	0.51	0.012	0.016	0.020	
K	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

С В 0.10 Α 0.05 С e/2 4X E2 F3 D2 G **BOTTOM VIEW**



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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